

US00D385808S

United States Patent [19]
Kim

[11] **Patent Number:** **Des. 385,808**
[45] **Date of Patent:** ****Nov. 4, 1997**

[54] **ELECTROMETER**

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[73] **Assignee:** **Metex Corporation**, Seoul, Rep. of Korea

[**] **Term:** **14 Years**

[21] **Appl. No.:** **52,659**

[22] **Filed:** **Apr. 2, 1996**

[30] **Foreign Application Priority Data**

Oct. 25, 1995 [KR] Rep. of Korea 95-20703

[51] **LOC (6) Cl.** **10-04**

[52] **U.S. Cl.** **D10/78**

[58] **Field of Search** D10/78; 324/72.5,
324/73.1, 110, 115, 149, 151 R, 151 A,
156

[56] **References Cited**

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Garrett & Dunner

[57] **CLAIM**

The ornamental design for an electrometer, as shown and described.

DESCRIPTION

FIG. 1 is a front view showing new design;
FIG. 2 is a rear view thereof;
FIG. 3 is a left side view thereof;
FIG. 4 is a right side view thereof;
FIG. 5 is a top plan view thereof;
FIG. 6 is a bottom plan view thereof;
FIG. 7 is a perspective view thereof; and,
FIG. 8 is a perspective view thereof with the stand extended.

1 Claim, 5 Drawing Sheets

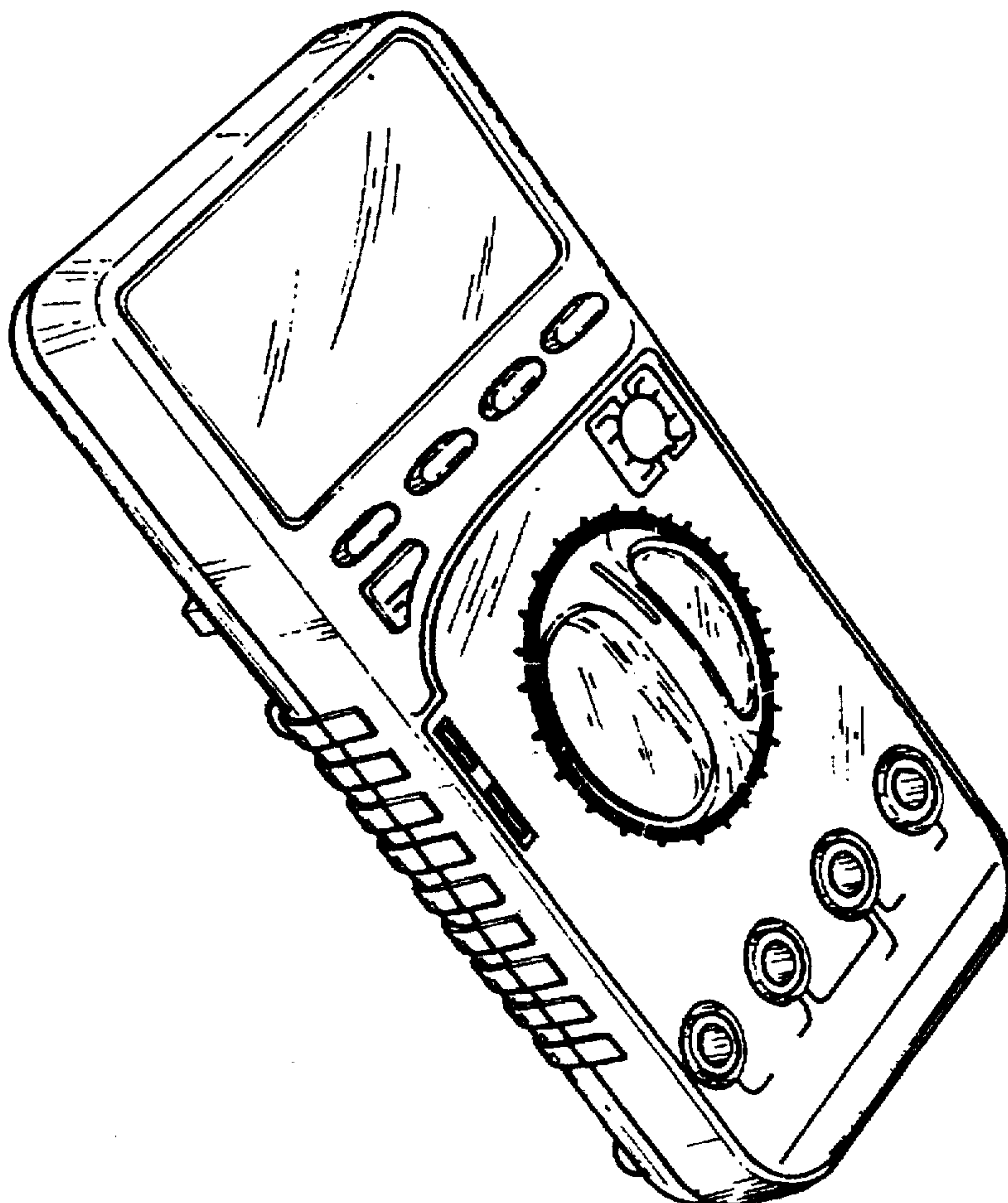


FIG.1

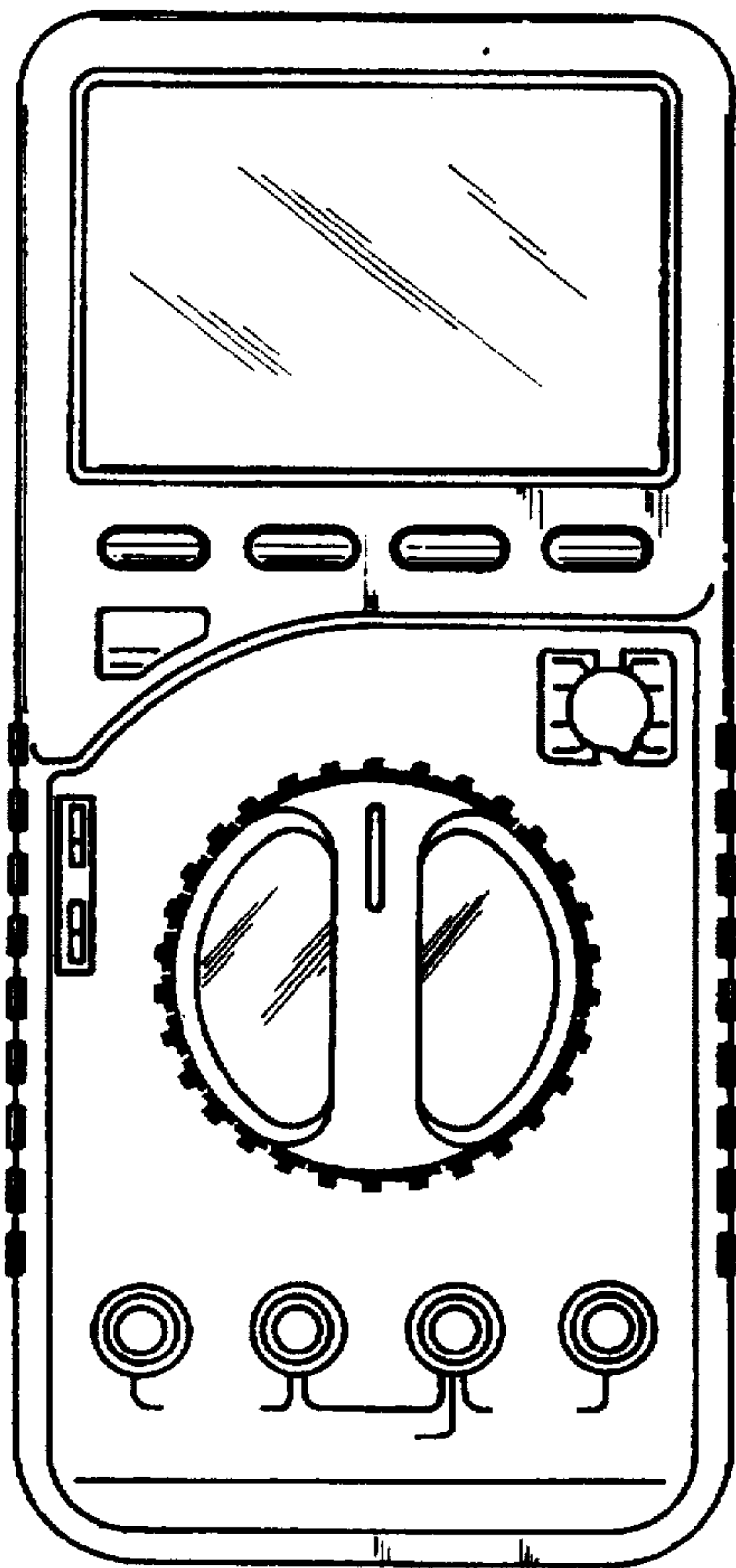


FIG.2

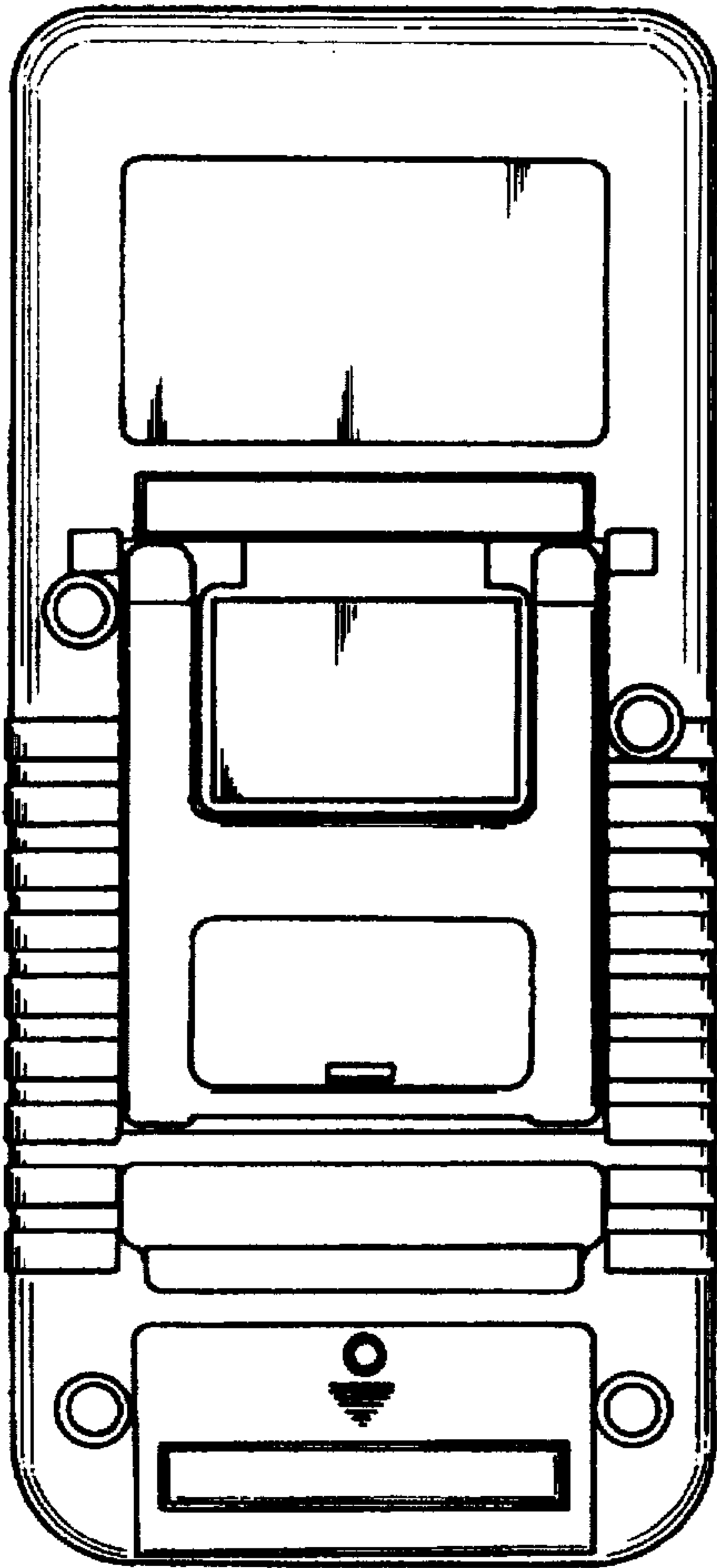


FIG. 3

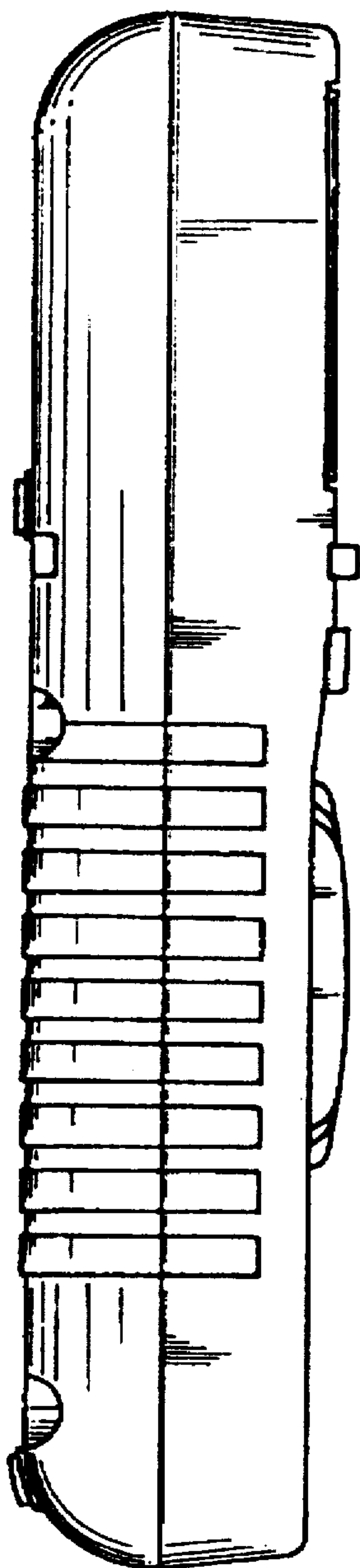


FIG. 4

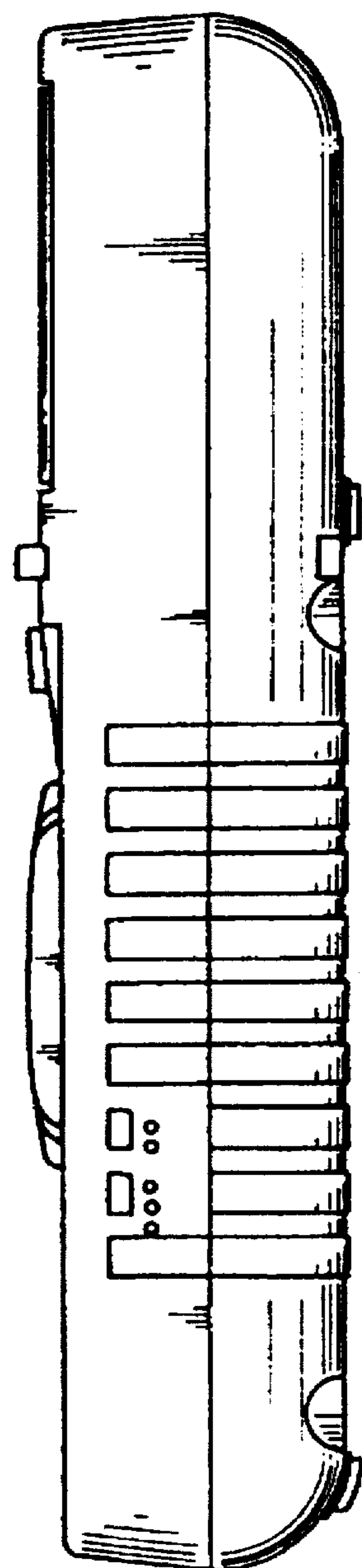


FIG. 5

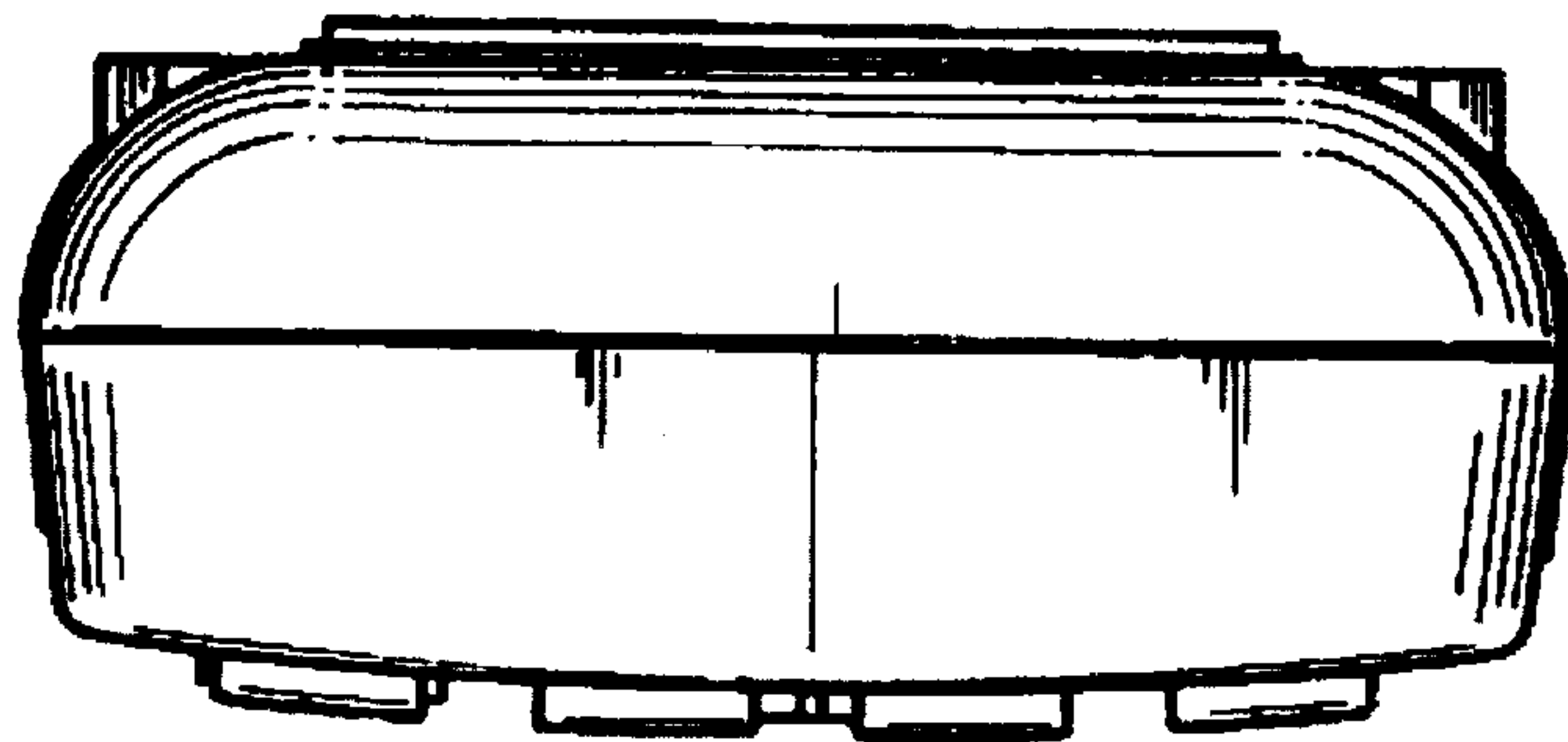


FIG. 6

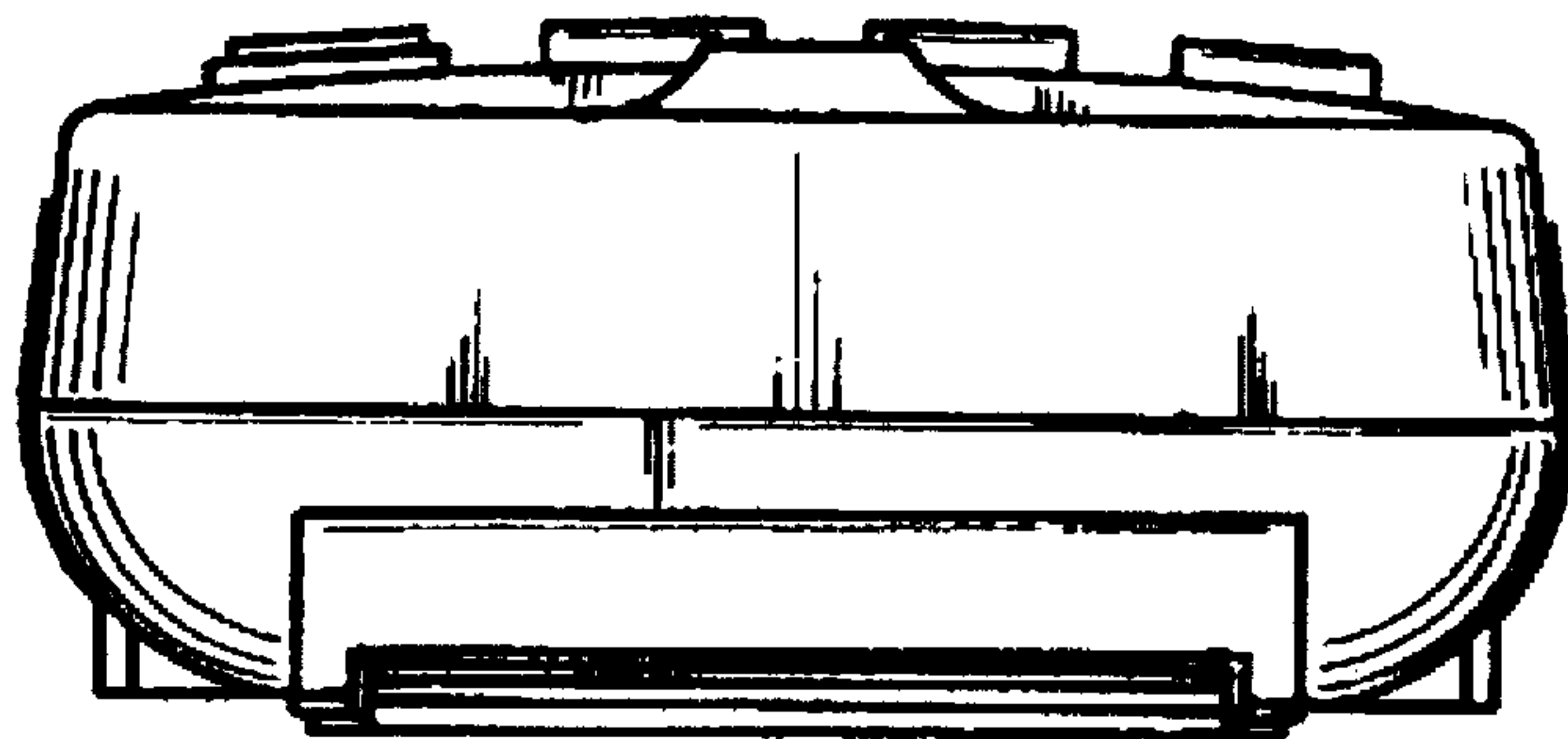


FIG. 7

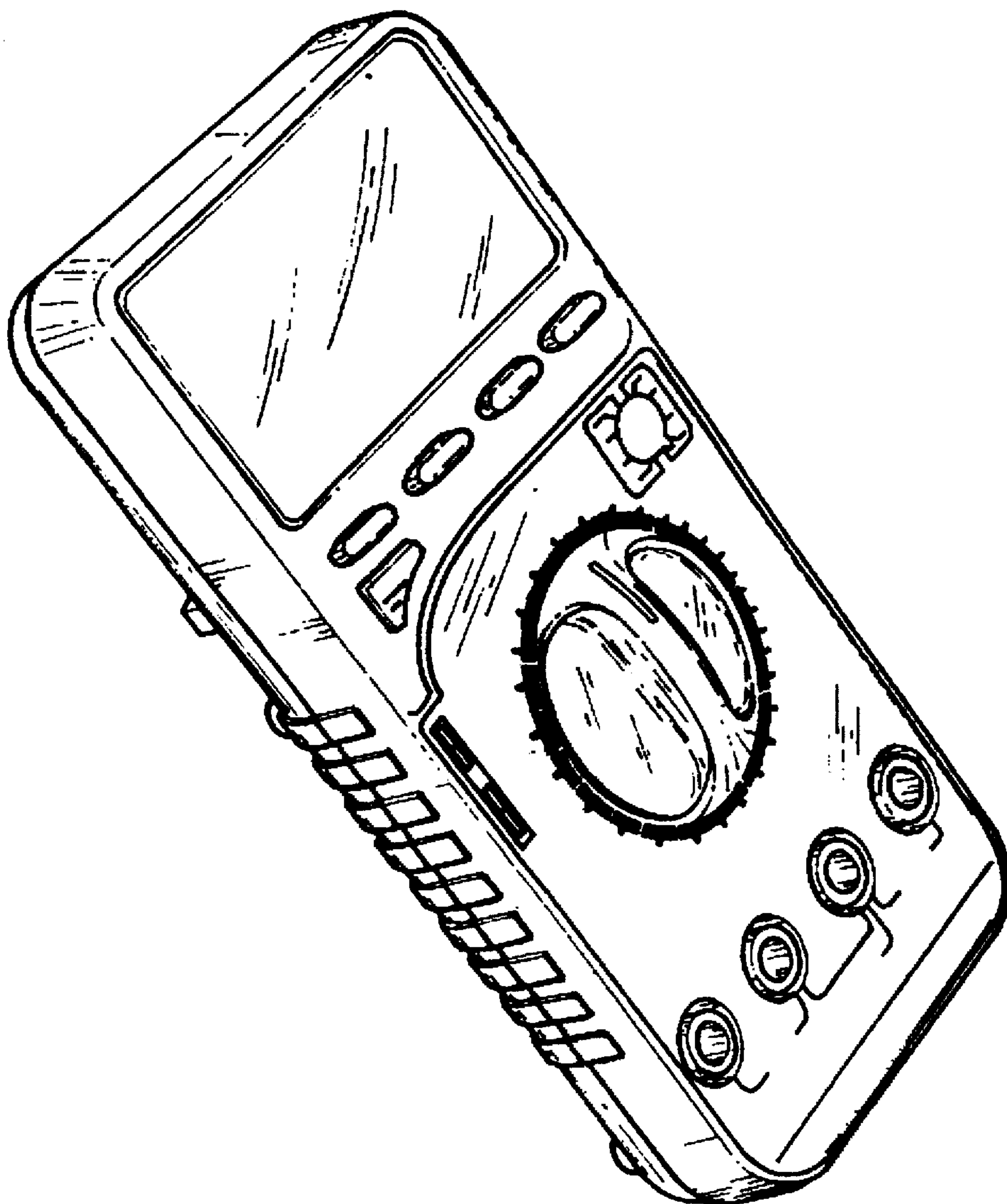


FIG. 8

